

Notice of References Cited

Application/Control No.

10/524,227

Applicant(s)/Patent Under
Reexamination
TANAKA ET AL.

Examiner

LINH T. NGUYEN

Art Unit

2627

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0020261	09-2001	Ando et al.	711/4
*	B	US-2002/0164149	11-2002	Wilkinson, James Hedley	386/46
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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	R					
	S					
	T					

NON-PATENT DOCUMENTS

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